

STH270N4F3-6

N-channel 40 V, 1.40 mΩ, 180 A, H²PAK STripFET™ III Power MOSFET

Features

Туре	V _{DSS}	R _{DS(on)}	I _D ⁽¹⁾
STH270N4F3-6	40 V	< 1.7 mΩ	180 A

- 1. Current limited by package
- Conduction losses reduced
- Low profile, very low parasitic inductance, high current package

Applications

- Switching application
 - Automotive

Description

This STripFET[™] III Power MOSFET technology is among the latest improvements, which have been especially tailored to minimize on-state resistance providing superior switching performance.

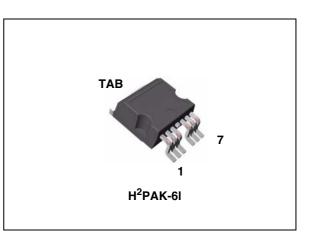


Figure 1. Internal schematic diagram

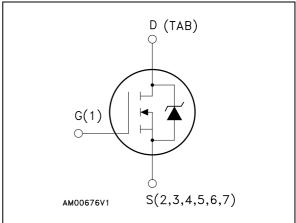


Table 1. Device summary

Order code	Marking Package Pa		Packaging
STH270N4F3-6	270N4F3	H ² PAK	Tape and reel

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1 Electrical ratings

Table 2.	Absolute	maximum	ratings
	Absolute	maximum	raungs

Symbol	Parameter	Value	Unit
V _{DS}	Drain-source voltage (v _{gs} = 0)	40	V
V _{GS}	Gate-source voltage	± 20	V
I _D ⁽¹⁾	Drain current (continuous) at $T_C = 25 \ ^{\circ}C$	180	Α
I _D	Drain current (continuous) at T _C = 100 °C	180	Α
I _{DM} ⁽¹⁾	Drain current (pulsed)	720	A
P _{TOT} ⁽²⁾	Total dissipation at $T_{C} = 25 \ ^{\circ}C$	300	w
	Derating factor	2	W/°C
E _{AS} ⁽³⁾	Single pulse avalanche energy	1000	mJ
T _{stg}	Storage temperature	-55 to 175	°C
Тj	Operating junction temperature		

1. Current limited by package

2. This value is rated according to Rthj-c

3. Starting Tj = 25 °C, I_D = 80 A, V_{DD} = 32 V

Symbol	Parameter	Value	Unit
R _{thj-case}	Thermal resistance junction-case max	0.5	°C/W
R _{thj-pcb} ⁽¹⁾	Thermal resistance junction-pcb max	35	°C/W

1. When mounted on 1 inch2 FR-4 2 oz Cu.



2 Electrical characteristics

(Tcase =25°C unless otherwise specified)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V _{(BR)DSS}	Drain-source breakdown voltage	$I_{D} = 250 \mu A, V_{GS} = 0$	40			V
I _{DSS}	Zero gate voltage drain current ($V_{GS} = 0$)	V_{DS} = Max rating, V_{DS} = Max rating, T _c =125°C			10 100	μA μA
I _{GSS}	Gate body leakage current (V _{DS} = 0)	$V_{DS} = \pm 20V$			±200	nA
V _{GS(th)}	Gate threshold voltage	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	2		4	V
R _{DS(on)}	Static drain-source on resistance	V _{GS} = 10V, I _D = 80A		1.40	1.70	mΩ

Table 4. On /off states

Table 5. Dynamic

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
g _{fs} ⁽¹⁾	Forward transconductance	V _{DS} = 10V _, I _D = 100A		200		S
C _{iss} C _{oss} C _{rss}	Input capacitance Output capacitance Reverse transfer capacitance	V _{DS} = 25V, f = 1 MHz, V _{GS} =0		7400 1800 50		pF pF pF
Q _g Q _{gs} Q _{gd}	Total gate charge Gate-source charge Gate-drain charge	V _{DD} = 20V, I _D = 160A, V _{GS} = 10V <i>(see Figure 14)</i>		110 30 25	150	nC nC nC

1. Pulsed: Pulse duration = 300 µs, duty cycle 1.5%

Table 6.	Switching	times
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Symbol	Parameter	Test conditions	Min.	Тур.	Max	Unit
t _{d(on)} t _r	Turn-on delay time Rise time	$V_{DD} = 20V, I_D = 80A$ $R_G = 4.7\Omega, V_{GS} = 10V,$ (see Figure 13)		25 180		ns ns
t _{d(off)} t _f	Turn-off delay time Fall time	$V_{DD} = 20V, I_D = 80A$ $R_G = 4.7\Omega, V_{GS} = 10V,$ (see Figure 13)		110 45		ns ns



Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
I _{SD} I _{SD} ⁽¹⁾	Source-drain current Source-drain current (pulsed)				180 720	A A
V _{SD} ⁽²⁾	Forward on voltage	I _{SD} = 180 A, V _{GS} = 0			1.5	V
t _{rr} Q _{rr} I _{RRM}	Reverse recovery time Reverse recovery charge Reverse recovery current	$I_{SD} = 160 \text{ A,di/dt} = 100 \text{ A/}\mu\text{s}$ $V_{DD} = 32\text{ V, T}_{j} = 150^{\circ}\text{C}$ (see Figure 15)		70 225 3.2		ns nC A

Table 7.Source drain diode

1. Pulse width limited by safe operating area

2. Pulsed: Pulse duration = 300 μ s, duty cycle 1.5%



2.1 Electrical characteristics (curves)

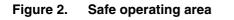
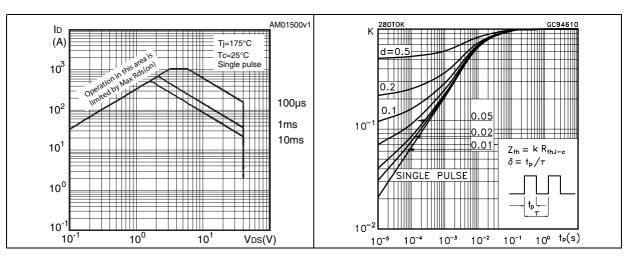
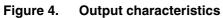
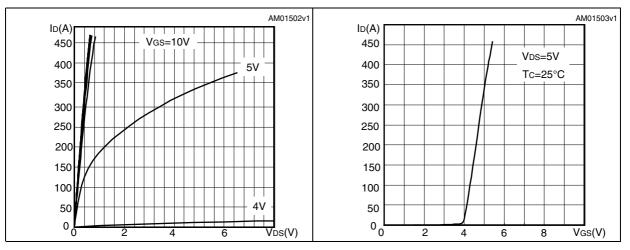


Figure 3. Thermal impedance









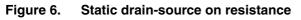
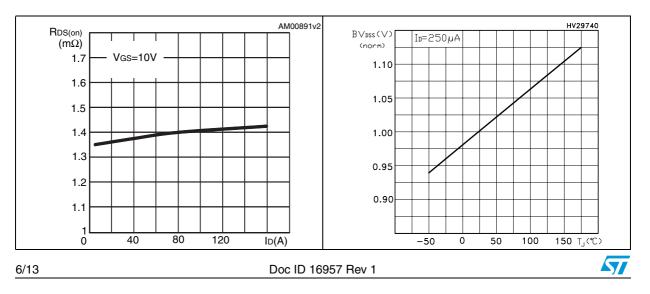


Figure 7. Norma

Normalized B_{VDSS} vs temperature



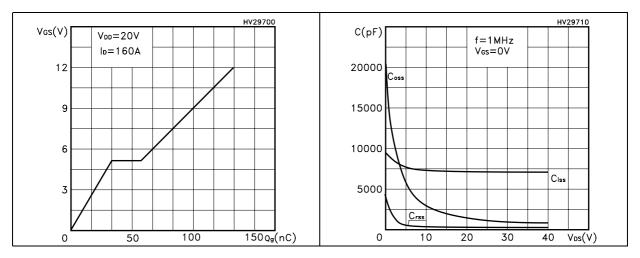


Figure 8. Gate charge vs gate-source voltage Figure 9. Capacitance variations

Figure 10. Normalized gate threshold voltage Figure 11. vs temperature

re 11. Normalized on resistance vs temperature

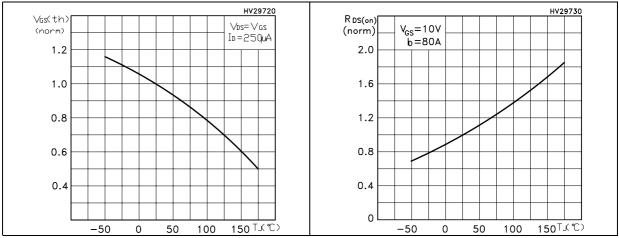
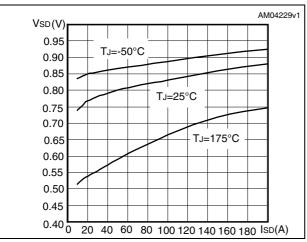
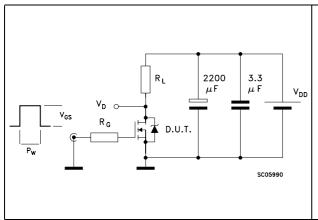


Figure 12. Source-drain diode forward characteristics



3 Test circuits

Figure 13. Switching times test circuit for resistive load



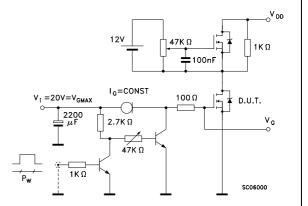
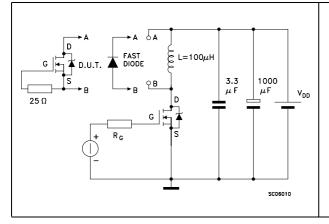
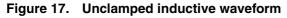
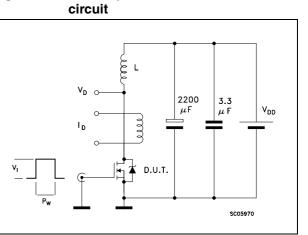


Figure 15. Test circuit for inductive load Figure 16. switching and diode recovery times

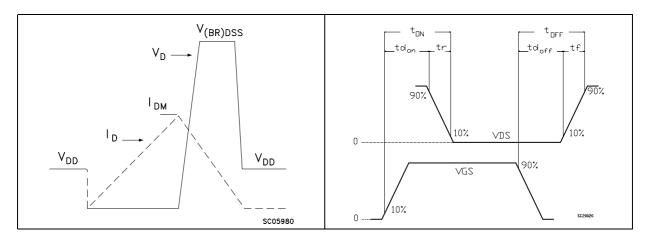






Unclamped inductive load test





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4 Package mechanical data

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK[®] packages, depending on their level of environmental compliance. ECOPACK[®] specifications, grade definitions and product status are available at: www.st.com. ECOPACK is an ST trademark.

Dim.	mm		
	Min.	Тур.	Max.
A	4.30		4.80
A1	0.03		0.20
С	1.17		1.37
е	2.34		2.74
e1	4.88		5.28
e2	7.42		7.82
E	0.45		0.60
F	0.50		0.70
Н	10.00		10.40
H1	7.80	-	8.20
L	14.75		15.25
L1	1.27		1.40
L2	4.35		4.95
L3	7.45		7.85
L4	1.5		1.75
М	1.90		2.50
R	0.20		0.60
V	0°		8°

 Table 8.
 H²PAK 6 leads mechanical data





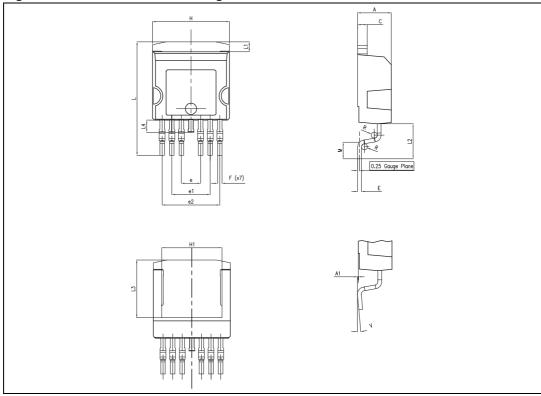
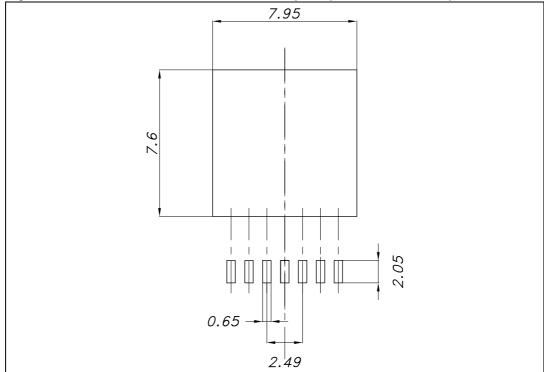


Figure 20. H²PAK 6 leads recommended footprint (dimensions in mm)





5 Packaging mechanical data

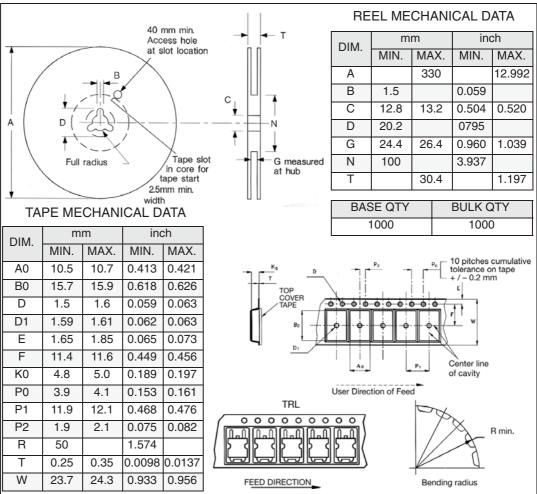


Figure 21. H²PAK 6 leads tape and reel



6 Revision history

Table 9.Document revision history

Date	Revision	Changes
15-Jan-2010	1	Initial release



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